

# MC74VHC373

## Octal D-Type Latch with 3-State Output

The MC74VHC373 is an advanced high speed CMOS octal latch with 3-state output fabricated with silicon gate CMOS technology. It achieves high speed operation similar to equivalent Bipolar Schottky TTL while maintaining CMOS low power dissipation.

This 8-bit D-type latch is controlled by a latch enable input and an output enable input. When the output enable input is high, the eight outputs are in a high impedance state.

The internal circuit is composed of three stages, including a buffer output which provides high noise immunity and stable output. The inputs tolerate voltages up to 7.0 V, allowing the interface of 5.0 V systems to 3.0 V systems.

### Features

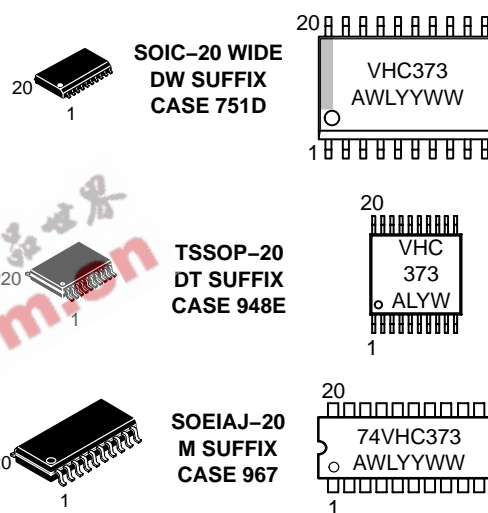
- High Speed:  $t_{PD} = 5.0$  ns (Typ) at  $V_{CC} = 5.0$  V
- Low Power Dissipation:  $I_{CC} = 4.0$   $\mu$ A (Max) at  $T_A = 25^\circ$ C
- High Noise Immunity:  $V_{NIH} = V_{NIL} = 28\%$   $V_{CC}$
- Power Down Protection Provided on Inputs
- Balanced Propagation Delays
- Designed for 2.0 V to 5.5 V Operating Range
- Low Noise:  $V_{OLP} = 0.9$  V (Max)
- Pin and Function Compatible with Other Standard Logic Families
- Latchup Performance Exceeds 300 mA
- ESD Performance: HBM > 2000 V; Machine Model > 200 V
- Chip Complexity: 186 FETs or 46.5 Equivalent Gates
- Pb-Free Packages are Available\*



ON Semiconductor®

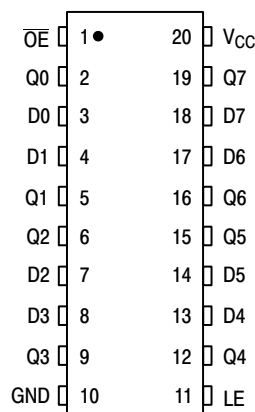
<http://onsemi.com>

### MARKING DIAGRAMS



A = Assembly Location  
WL, L = Wafer Lot  
YY, Y = Year  
WW, W = Work Week

### PIN ASSIGNMENT



### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 4 of this data sheet.

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

## MC74VHC373

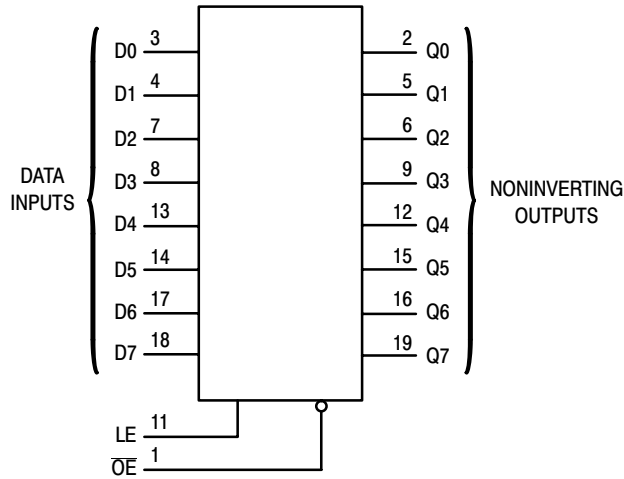


Figure 1. Logic Diagram

FUNCTION TABLE

| INPUTS |    |   | OUTPUT    |
|--------|----|---|-----------|
| OE     | LE | D | Q         |
| L      | H  | H | H         |
| L      | H  | L | L         |
| L      | L  | X | No Change |
| H      | X  | X | Z         |

### MAXIMUM RATINGS

| Symbol    | Parameter  | Value                   | Unit |
|-----------|--|-------------------------|------|
| $V_{CC}$  | DC Supply Voltage  | - 0.5 to + 7.0          | V    |
| $V_{in}$  | DC Input Voltage   | - 0.5 to + 7.0          | V    |
| $V_{out}$ | DC Output Voltage  | - 0.5 to $V_{CC} + 0.5$ | V    |
| $I_{IK}$  | Input Diode Current  | - 20                    | mA   |
| $I_{OK}$  | Output Diode Current   | ± 20                    | mA   |
| $I_{out}$ | DC Output Current, per Pin                                     | ± 25                    | mA   |
| $I_{CC}$  | DC Supply Current, $V_{CC}$ and GND Pins                       | ± 75                    | mA   |
| $P_D$     | Power Dissipation in Still Air, SOIC Packages†, TSSOP Package† | 500<br>450              | mW   |
| $T_{stg}$ | Storage Temperature  | - 65 to + 150           | °C   |

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high-impedance circuit. For proper operation,  $V_{in}$  and  $V_{out}$  should be constrained to the range  $GND \leq (V_{in} \text{ or } V_{out}) \leq V_{CC}$ . Unused inputs must always be tied to an appropriate logic voltage level (e.g., either GND or  $V_{CC}$ ). Unused outputs must be left open.

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

†Derating — SOIC Packages: - 7 mW/°C from 65° to 125°C  
TSSOP Package: - 6.1 mW/°C from 65° to 125°C

### RECOMMENDED OPERATING CONDITIONS

| Symbol     | Parameter                | Min  | Max       | Unit |
|------------|--------------------------|--|-----------|------|
| $V_{CC}$   | DC Supply Voltage        | 2.0  | 5.5       | V    |
| $V_{in}$   | DC Input Voltage         | 0  | 5.5       | V    |
| $V_{out}$  | DC Output Voltage        | 0  | $V_{CC}$  | V    |
| $T_A$      | Operating Temperature    | - 40   | + 85      | °C   |
| $t_r, t_f$ | Input Rise and Fall Time | $V_{CC} = 3.3 \text{ V}$<br>0<br>$V_{CC} = 5.0 \text{ V}$<br>0 | 100<br>20 | ns/V |

# MC74VHC373

## DC ELECTRICAL CHARACTERISTICS

| Symbol          | Parameter                           | Test Conditions  | V <sub>CC</sub><br>V | T <sub>A</sub> = 25°C         |                   |                               | T <sub>A</sub> = - 40 to 85°C |                               | Unit |
|-----------------|-------------------------------------|--|----------------------|-------------------------------|-------------------|-------------------------------|-------------------------------|-------------------------------|------|
|                 |                                     |  |                      | Min                           | Typ               | Max                           | Min                           | Max                           |      |
| V <sub>IH</sub> | Minimum High-Level Input Voltage    |  | 2.0<br>3.0 to 5.5    | 1.50<br>V <sub>CC</sub> × 0.7 |                   |                               | 1.50<br>V <sub>CC</sub> × 0.7 |                               | V    |
| V <sub>IL</sub> | Maximum Low-Level Input Voltage     |  | 2.0<br>3.0 to 5.5    |                               |                   | 0.50<br>V <sub>CC</sub> × 0.3 |                               | 0.50<br>V <sub>CC</sub> × 0.3 | V    |
| V <sub>OH</sub> | Minimum High-Level Output Voltage   | V <sub>in</sub> = V <sub>IH</sub> or V <sub>IL</sub><br>I <sub>OH</sub> = - 50 μA                            | 2.0<br>3.0<br>4.5    | 1.9<br>2.9<br>4.4             | 2.0<br>3.0<br>4.5 |                               | 1.9<br>2.9<br>4.4             |                               | V    |
|                 |                                     | V <sub>in</sub> = V <sub>IH</sub> or V <sub>IL</sub><br>I <sub>OH</sub> = - 4 mA<br>I <sub>OH</sub> = - 8 mA | 3.0<br>4.5           | 2.58<br>3.94                  |                   |                               | 2.48<br>3.80                  |                               |      |
| V <sub>OL</sub> | Maximum Low-Level Output Voltage    | V <sub>in</sub> = V <sub>IH</sub> or V <sub>IL</sub><br>I <sub>OL</sub> = 50 μA                              | 2.0<br>3.0<br>4.5    |                               | 0.0<br>0.0<br>0.0 | 0.1<br>0.1<br>0.1             |                               | 0.1<br>0.1<br>0.1             | V    |
|                 |                                     | V <sub>in</sub> = V <sub>IH</sub> or V <sub>IL</sub><br>I <sub>OL</sub> = 4 mA<br>I <sub>OL</sub> = 8 mA     | 3.0<br>4.5           |                               |                   | 0.36<br>0.36                  |                               | 0.44<br>0.44                  |      |
| I <sub>in</sub> | Maximum Input Leakage Current       | V <sub>in</sub> = 5.5 V or GND   | 0 to 5.5             |                               |                   | ± 0.1                         |                               | ± 1.0                         | μA   |
| I <sub>OZ</sub> | Maximum Three-State Leakage Current | V <sub>in</sub> = V <sub>IL</sub> or V <sub>IH</sub><br>V <sub>out</sub> = V <sub>CC</sub> or GND            | 5.5                  |                               |                   | ± 0.25                        |                               | ± 2.5                         | μA   |
| I <sub>CC</sub> | Maximum Quiescent Supply Current    | V <sub>in</sub> = V <sub>CC</sub> or GND   | 5.5                  |                               |                   | 4.0                           |                               | 40.0                          | μA   |

## AC ELECTRICAL CHARACTERISTICS (Input t<sub>r</sub> = t<sub>f</sub> = 3.0ns)

| Symbol                                   | Parameter                             | Test Conditions  | T <sub>A</sub> = 25°C |            |              | T <sub>A</sub> = - 40 to 85°C |              | Unit |
|--|---------------------------------------|--|-----------------------|------------|--------------|-------------------------------|--------------|------|
|  |                                       |  | Min                   | Typ        | Max          | Min                           | Max          |      |
| t <sub>PLH</sub> ,<br>t <sub>PHL</sub>   | Maximum Propagation Delay,<br>D to Q  | V <sub>CC</sub> = 3.3 ± 0.3 V C <sub>L</sub> = 15 pF<br>C <sub>L</sub> = 50 pF                       |                       | 7.3<br>9.8 | 11.4<br>14.9 | 1.0<br>1.0                    | 13.5<br>17.0 | ns   |
|  |                                       | V <sub>CC</sub> = 5.0 ± 0.5 V C <sub>L</sub> = 15 pF<br>C <sub>L</sub> = 50 pF                       |                       | 4.9<br>6.4 | 7.2<br>9.2   | 1.0<br>1.0                    | 8.5<br>10.5  |      |
| t <sub>PLH</sub> ,<br>t <sub>PHL</sub>   | Maximum Propagation Delay,<br>LE to Q | V <sub>CC</sub> = 3.3 ± 0.3 V C <sub>L</sub> = 15 pF<br>C <sub>L</sub> = 50 pF                       |                       | 7.0<br>9.5 | 11.0<br>14.5 | 1.0<br>1.0                    | 13.0<br>16.5 | ns   |
|  |                                       | V <sub>CC</sub> = 5.0 ± 0.5 V C <sub>L</sub> = 15 pF<br>C <sub>L</sub> = 50 pF                       |                       | 5.0<br>6.5 | 7.2<br>9.2   | 1.0<br>1.0                    | 8.5<br>10.5  |      |
| t <sub>PZL</sub> ,<br>t <sub>PZH</sub>   | Output Enable Time,<br>OE to Q        | V <sub>CC</sub> = 3.3 ± 0.3 V C <sub>L</sub> = 15 pF<br>R <sub>L</sub> = 1 kΩ C <sub>L</sub> = 50 pF |                       | 7.3<br>9.8 | 11.4<br>14.9 | 1.0<br>1.0                    | 13.5<br>17.0 | ns   |
|  |                                       | V <sub>CC</sub> = 5.0 ± 0.5 V C <sub>L</sub> = 15 pF<br>R <sub>L</sub> = 1 kΩ C <sub>L</sub> = 50 pF |                       | 5.5<br>7.0 | 8.1<br>10.1  | 1.0<br>1.0                    | 9.5<br>11.5  |      |
| t <sub>PLZ</sub> ,<br>t <sub>PHZ</sub>   | Output Disable Time,<br>OE to Q       | V <sub>CC</sub> = 3.3 ± 0.3 V C <sub>L</sub> = 50 pF<br>R <sub>L</sub> = 1 kΩ                        |                       | 9.5        | 13.2         | 1.0                           | 15.0         | ns   |
|  |                                       | V <sub>CC</sub> = 5.0 ± 0.5 V C <sub>L</sub> = 50 pF<br>R <sub>L</sub> = 1 kΩ                        |                       | 6.5        | 9.2          | 1.0                           | 10.5         |      |
| t <sub>OSLH</sub> ,<br>t <sub>OSHL</sub> | Output to Output Skew                 | V <sub>CC</sub> = 3.3 ± 0.3 V C <sub>L</sub> = 50 pF<br>(Note 1)                                     |                       |            | 1.5          |                               | 1.5          | ns   |
|  |                                       | V <sub>CC</sub> = 5.5 ± 0.5 V C <sub>L</sub> = 50 pF<br>(Note 1)                                     |                       |            | 1.0          |                               | 1.0          | ns   |

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## AC ELECTRICAL CHARACTERISTICS (Input $t_r = t_f = 3.0\text{ns}$ )

| Symbol           | Parameter   | Test Conditions | T <sub>A</sub> = 25°C |     |     | T <sub>A</sub> = – 40 to 85°C |     | Unit |
|------------------|---|-----------------|-----------------------|-----|-----|-------------------------------|-----|------|
|                  |   |                 | Min                   | Typ | Max | Min                           | Max |      |
| C <sub>in</sub>  | Maximum Input Capacitance   |                 |                       | 4   | 10  |                               | 10  | pF   |
| C <sub>out</sub> | Maximum Three-State Output Capacitance (Output in High-Impedance State) |                 |                       | 6   |     |                               |     | pF   |

|                 |  |   |    |
|-----------------|--|---|----|
| C <sub>PD</sub> | Power Dissipation Capacitance (Note 2) | Typical @ 25°C, V <sub>CC</sub> = 5.0 V | pF |
|                 |  | 27                                      |    |

- Parameter guaranteed by design.  $t_{OSLH} = |t_{PLHm} - t_{PLHn}|$ ,  $t_{OSHL} = |t_{PHLm} - t_{PHLn}|$ .
- $C_{PD}$  is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation:  $I_{CC(OPR)} = C_{PD} \cdot V_{CC} \cdot f_{in} + I_{CC}/8$  (per latch).  $C_{PD}$  is used to determine the no-load dynamic power consumption;  $P_D = C_{PD} \cdot V_{CC}^2 \cdot f_{in} + I_{CC} \cdot V_{CC}$ .

## NOISE CHARACTERISTICS (Input $t_r = t_f = 3.0\text{ns}$ , $C_L = 50\text{ pF}$ , $V_{CC} = 5.0\text{V}$ )

| Symbol    | Parameter                                | $T_A = 25^\circ\text{C}$ |      | Unit |
|-----------|--|--------------------------|------|------|
|           |  | Typ                      | Max  |      |
| $V_{OLP}$ | Quiet Output Maximum Dynamic $V_{OL}$    | 0.6                      | 0.9  | V    |
| $V_{OLV}$ | Quiet Output Minimum Dynamic $V_{OL}$    | -0.6                     | -0.9 | V    |
| $V_{IHD}$ | Minimum High Level Dynamic Input Voltage |                          | 3.5  | V    |
| $V_{ILD}$ | Maximum Low Level Dynamic Input Voltage  |                          | 1.5  | V    |

## TIMING REQUIREMENTS (Input $t_r = t_f = 3.0\text{ ns}$ )

| Symbol     | Parameter                   | Test Conditions  | $T_A = 25^\circ\text{C}$ |            | $T_A = -40 \text{ to } 85^\circ\text{C}$ | Unit |
|------------|-----------------------------|--|--------------------------|------------|--|------|
|            |                             |  | Typ                      | Limit      | Limit                                    |      |
| $t_{w(h)}$ | Minimum Pulse Width, LE     | $V_{CC} = 3.3 \pm 0.3\text{ V}$<br>$V_{CC} = 5.0 \pm 0.5\text{ V}$ |                          | 5.0<br>5.0 | 5.0<br>5.0                               | ns   |
| $t_{su}$   | Minimum Setup Time, D to LE | $V_{CC} = 3.3 \pm 0.3\text{ V}$<br>$V_{CC} = 5.0 \pm 0.5\text{ V}$ |                          | 4.0<br>4.0 | 4.0<br>4.0                               | ns   |
| $t_h$      | Minimum Hold Time, D to LE  | $V_{CC} = 3.3 \pm 0.3\text{ V}$<br>$V_{CC} = 5.0 \pm 0.5\text{ V}$ |                          | 1.0<br>1.0 | 1.0<br>1.0                               | ns   |

## ORDERING INFORMATION

| Device          | Package                | Shipping†        |
|-----------------|------------------------|------------------|
| MC74VHC373DWR2  | SOIC-20                | 1000 Tape & Reel |
| MC74VHC373DWR2G | SOIC-20<br>(Pb-Free)   | 1000 Tape & Reel |
| MC74VHC373DTR2  | TSSOP-20*              | 2500 Tape & Reel |
| MC74VHC373MEL   | SOEIAJ-20              | 2000 Tape & Reel |
| MC74VHC373MELG  | SOEIAJ-20<br>(Pb-Free) | 2000 Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

\*This package is inherently Pb-Free.

# MC74VHC373

## SWITCHING WAVEFORMS

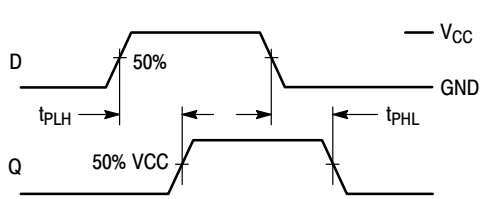


Figure 2.

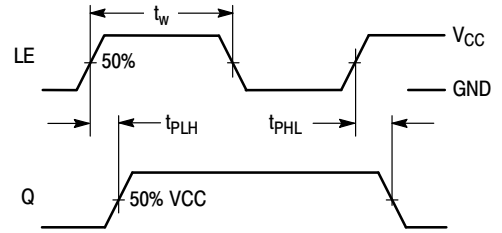


Figure 3.

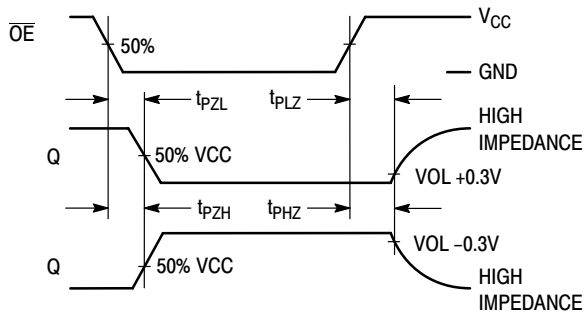


Figure 4.

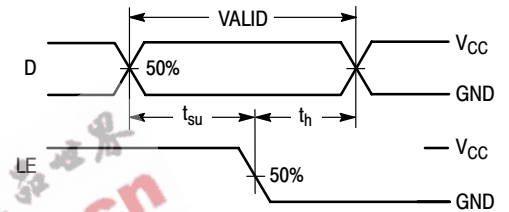
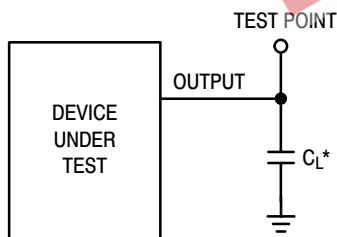


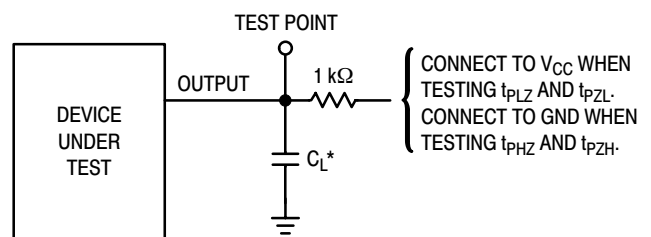
Figure 5.

## TEST CIRCUITS



\*Includes all probe and jig capacitance

Figure 6.



\*Includes all probe and jig capacitance

Figure 7.

## MC74VHC373

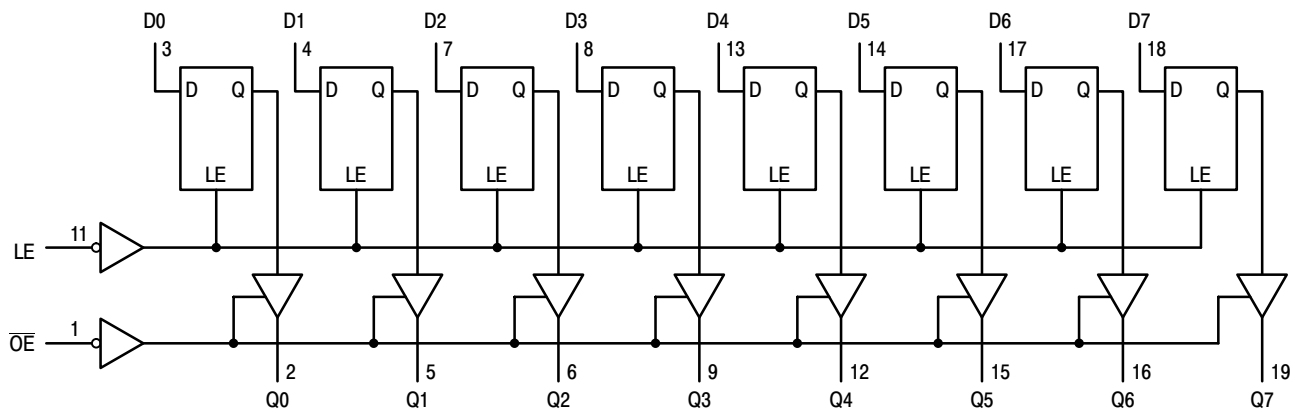


Figure 8. EXPANDED LOGIC DIAGRAM

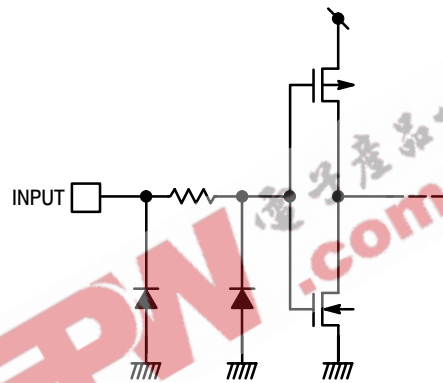
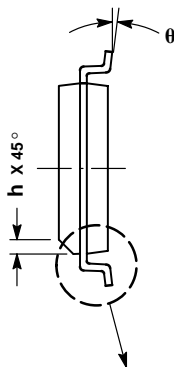
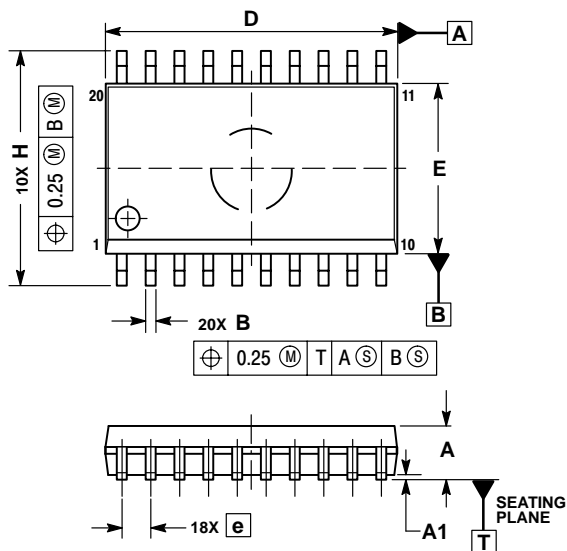


Figure 9. INPUT EQUIVALENT CIRCUIT

# MC74VHC373

## OUTLINE DIMENSIONS

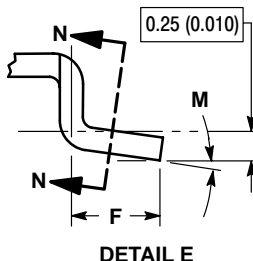
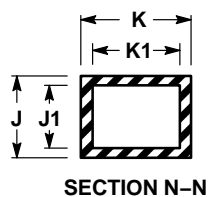
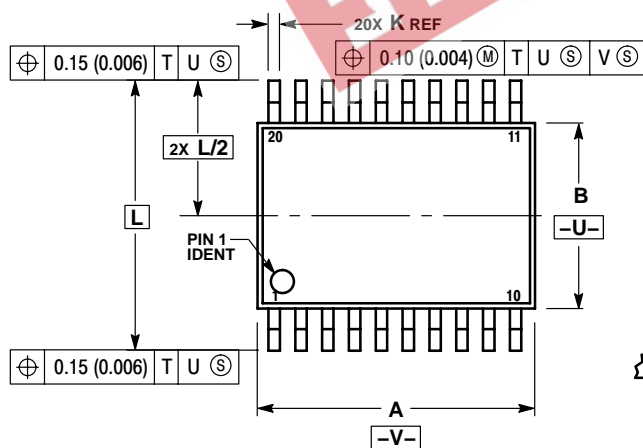
SOIC-20  
DW SUFFIX  
CASE 751D-05  
ISSUE G



- NOTES:
1. DIMENSIONS ARE IN MILLIMETERS.
  2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.
  3. DIMENSIONS D AND E DO NOT INCLUDE MOLD PROTRUSION.
  4. MAXIMUM MOLD PROTRUSION 0.15 PER SIDE.
  5. DIMENSION B DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF B DIMENSION AT MAXIMUM MATERIAL CONDITION.

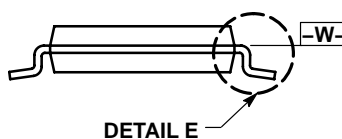
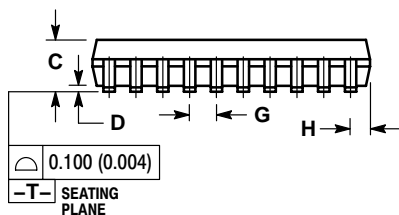
| DIM   | MILLIMETERS |       |
|-------|-------------|-------|
|       | MIN         | MAX   |
| A     | 2.35        | 2.65  |
| A1    | 0.10        | 0.25  |
| B     | 0.35        | 0.49  |
| C     | 0.23        | 0.32  |
| D     | 12.65       | 12.95 |
| E     | 7.40        | 7.60  |
| e     | 1.27 BSC    |       |
| H     | 10.05       | 10.55 |
| h     | 0.25        | 0.75  |
| L     | 0.50        | 0.90  |
| theta | 0°          | 7°    |

TSSOP-20  
DT SUFFIX  
CASE 948E-02  
ISSUE B



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
  4. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
  5. DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
  6. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
  7. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE -W-.

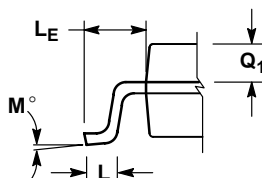
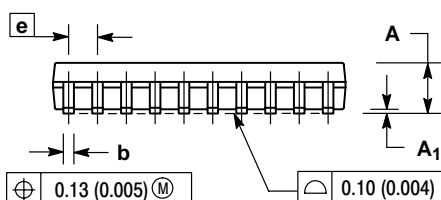
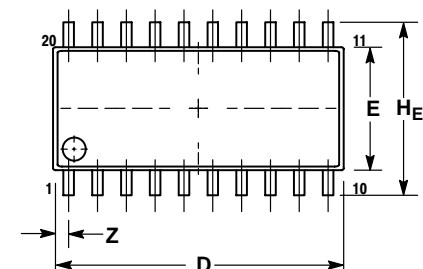
| DIM | MILLIMETERS |      | INCHES    |       |
|-----|-------------|------|-----------|-------|
|     | MIN         | MAX  | MIN       | MAX   |
| A   | 6.40        | 6.60 | 0.252     | 0.260 |
| B   | 4.30        | 4.50 | 0.169     | 0.177 |
| C   | ---         | 1.20 | ---       | 0.047 |
| D   | 0.05        | 0.15 | 0.002     | 0.006 |
| F   | 0.50        | 0.75 | 0.020     | 0.030 |
| G   | 0.65 BSC    |      | 0.026 BSC |       |
| H   | 0.27        | 0.37 | 0.011     | 0.015 |
| J   | 0.09        | 0.20 | 0.004     | 0.008 |
| J1  | 0.09        | 0.16 | 0.004     | 0.006 |
| K   | 0.19        | 0.30 | 0.007     | 0.012 |
| K1  | 0.19        | 0.25 | 0.007     | 0.010 |
| L   | 6.40 BSC    |      | 0.252 BSC |       |
| M   | 0°          | 8°   | 0°        | 8°    |



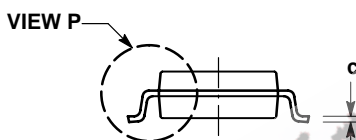
# MC74VHC373

## OUTLINE DIMENSIONS

SOEIAJ-20  
M SUFFIX  
CASE 967-01  
ISSUE O




DETAIL P



### NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS AND ARE MEASURED AT THE PARTING LINE. MOLD FLASH OR PROTRUSIONS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
4. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
5. THE LEAD WIDTH DIMENSION (b) DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE LEAD WIDTH DIMENSION AT MAXIMUM MATERIAL CONDITION. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT. MINIMUM SPACE BETWEEN PROTRUSIONS AND ADJACENT LEAD TO BE 0.46 (0.018).

| DIM            | MILLIMETERS |       | INCHES    |       |
|----------------|-------------|-------|-----------|-------|
|                | MIN         | MAX   | MIN       | MAX   |
| A              | ---         | 2.05  | ---       | 0.081 |
| A <sub>1</sub> | 0.05        | 0.20  | 0.002     | 0.008 |
| b              | 0.35        | 0.50  | 0.014     | 0.020 |
| c              | 0.18        | 0.27  | 0.007     | 0.011 |
| D              | 12.35       | 12.80 | 0.486     | 0.504 |
| E              | 5.10        | 5.45  | 0.201     | 0.215 |
| e              | 1.27 BSC    |       | 0.050 BSC |       |
| H <sub>E</sub> | 7.40        | 8.20  | 0.291     | 0.323 |
| L              | 0.50        | 0.85  | 0.020     | 0.033 |
| L <sub>E</sub> | 1.10        | 1.50  | 0.043     | 0.059 |
| M              | 0°          | 10°   | 0°        | 10°   |
| Q <sub>1</sub> | 0.70        | 0.90  | 0.028     | 0.035 |
| Z              | ---         | 0.81  | ---       | 0.032 |

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